

Notice of References Cited	Application/Control No. 10/624,148	Applicant(s)/Patent Under Reexamination TAWA ET AL	
	Examiner MUHAMMAD N EDUN	Art Unit 2655	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-6,359,845	03-2002	Lee et al.	369/44.23
X	B	US-6,590,851	07-2003	Kim et al.	369/112.01
X	C	US-6,650,612	11-2003	Matsuzaki et al.	369/112.05
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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